

Short circuit rugged 1200 V TRENCHSTOP™ IGBT 7 technology copacked with soft and fast recovery Emitter Controlled 7 diode

Features

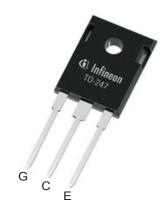
- V_{CE}=1200 V
- I_C=25 A
- IGBT co-packed with full current, soft and low Qrr diode
- Low saturation voltage $V_{CE(sat)} = 2.0 \text{ V}$ at $T_{vj} = 175 \,^{\circ}\text{C}$
- Optimized for hard switching topologies (2-L inverter, 3-L NPC T-type, ...)
- Short circuit ruggedness 8 µsec
- Wide range of dv/dt controllability
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

Potential applications

- Industrial Drives
- Industrial Power Supplies
- Solar Inverters

Product validation

 Product Validation: Qualified for industrial applications according to the relevant tests of JEDEC47/20/22



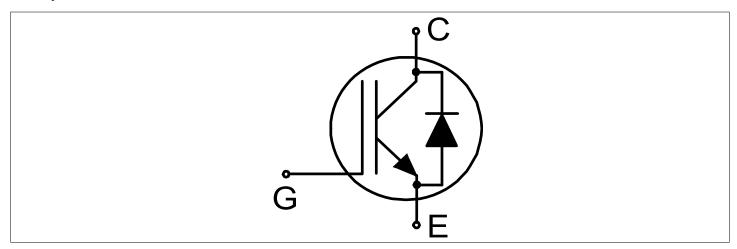








Description



Туре	Package	Marking
IKW25N120CS7	PG-TO247-3	K25MCS7



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Short circuit rugged 1200 V TRENCHSTOP™ IGBT 7 technology



1 Package

1 Package

Table 1 Characteristic values

Parameter	Symbol	Symbol Note or test condition	Values			Unit
			Min.	Тур.	Max.	
Internal emitter inductance measured 5mm. (0.197in) from case	L _E			13.0		nH
Storage temperature	$T_{\rm stg}$		-55		150	°C
Soldering temperature		wave soldering 1.6mm (0.063in.) from case for 10s			260	°C
Mounting torque, M3 screw Maximum of mounting process: 3	М				0.6	Nm
Thermal resistance, junction-ambient	$R_{th(j-a)}$				40	K/W

2 IGBT

Table 2 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Collector-emitter voltage	V _{CE}	<i>T</i> _{vj} ≥ 25 °C	<i>T</i> _{vj} ≥ 25 °C		V
DC collector current, limited	I _C	To	_C = 25 °C	55	А
by T _{vjmax}		To	c = 100 °C	37	
Pulsed collector current, t _p limited by T _{vjmax}	I _{Cpuls}			75	А
Turn-off safe operating area		$V_{\rm CE} \le 1200 \text{V}, T_{\rm vj} \le 175 ^{\circ}\text{C}$		75	А
Gate-emitter voltage	V _{GE}			±20	V
Transient gate-emitter voltage	V_{GE}	$t_{\rm p} \le 0.5 \mu {\rm s}, D < 0.001$	$t_{\rm p} \le 0.5 \ \mu {\rm s}, D < 0.001$		V
Short circuit withstand time	t _{SC}	$V_{\rm CC} \le 600$ V, $V_{\rm GE} = 15$ V, Allowed number of short circuits < 1000, Time between short circuits ≥ 1.0 s, $T_{\rm vi} = 150$ °C		8	μs
Power dissipation	P _{tot}	To	c = 25 °C	250	W
		To	c = 100 °C	125	

Table 3 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Collector-emitter saturation	V _{CE sat}	$I_{\rm C}$ = 25.0 A, $V_{\rm GE}$ = 15 V	T _{vj} = 25 °C		1.65	2.00	V
voltage			T _{vj} = 175 °C		2.00		

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2 IGBT

Table 3 Characteristic values (continued)

Parameter	Symbol	Note or test condition		Values			Unit
					Тур.	Max.	
Gate-emitter threshold voltage	V _{GEth}	$I_{\rm C}$ = 0.49 mA, $V_{\rm CE}$ = $V_{\rm GE}$, $T_{\rm vj}$	= 25 °C	5.15	5.70	6.45	V
Zero gate voltage collector	I _{CES}	$V_{CE} = 1200 \text{ V}, V_{GE} = 0 \text{ V}$	T _{vj} = 25 °C			40	μΑ
current			T _{vj} = 175 °C		2000		
Gate-emitter leakage current	I _{GES}	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$				100	nA
Transconductance	g_{fs}	$I_{\rm C}$ = 25.0 A, $V_{\rm CE}$ = 20 V, $T_{\rm vj}$ =	: 175 °C		11.0		S
Short circuit collector current	I _{SC}	$V_{CC} \le 600 \text{ V}, V_{GE} = 15 \text{ V}, t_{SC}$ number of short circuits solution between short circuits ≥ 10	< 1000 , Time		160		А
Input capacitance	C _{ies}	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 10$	0 kHz		3.5		nF
Output capacitance	C _{oes}	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 10$	0 kHz		80		pF
Reverse transfer capacitance	C _{res}	$V_{\text{CE}} = 25 \text{ V}, V_{\text{GE}} = 0 \text{ V}, f = 10$	0 kHz		17		pF
Gate charge	Q _G	$I_{\rm C}$ = 25.0 A, $V_{\rm GE}$ = 15 V, $V_{\rm CE}$	= 960 V		150		nC
Turn-on delay time	t _{don}	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$,		21		ns
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		21		
Rise time (inductive load)	t _r	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm C}$ = 25.0 A		13		ns
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		17		
Turn-off delay time	t _{doff}	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm C}$ = 25.0 A		160		ns
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		240		
Fall time (inductive load)	t _f	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$,		100		ns
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		250		
Turn-on energy	E _{on}	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$,		1.20		mJ
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		1.85		
Turn-off energy	E _{off}	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$,		1.10		mJ
			$T_{\rm vj}$ = 175 °C, $I_{\rm C}$ = 25.0 A		2.35		

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3 Diode

Table 3 Characteristic values (continued)

Parameter Total switching energy	Symbol	bol Note or test condition		Values			Unit
				Min.	Тур.	Max.	
	E _{ts}	$V_{\text{CE}} = 600 \text{ V}, V_{\text{GE}} = 15 \text{ V},$ $R_{\text{Gon}} = 6.0 \Omega, R_{\text{Goff}} = 6.0 \Omega$	$T_{\rm vj} = 25 ^{\circ}\text{C},$ $I_{\rm C} = 25.0 \text{A}$		2.30		mJ
			$T_{\rm vj} = 175 ^{\circ}\text{C},$ $I_{\rm C} = 25.0 \text{A}$		4.20		
IGBT thermal resistance, junction-case	R _{thjc}				0.45	0.60	K/W
Operating junction temperature	T _{vj}			-40		175	°C

3 Diode

Table 4 Maximum rated values

Parameter	Symbol	Note or test condition	on	Values	Unit
Repetitive peak reverse voltage	V_{RRM}	<i>T</i> _{vj} ≥ 25 °C		1200	V
Diode forward current, limited by T _{vjmax}	/ _F		T _C = 25 °C	41	А
			T _C = 100 °C	27	
Diode pulsed current, limited by T _{vjmax}	I _{Fpuls}		·	75	А
Power dissipation	P _{tot}		T _C = 25 °C	120	W
			T _C = 100 °C	60	

Table 5 Characteristic values

Parameter	Symbol	ol Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Diode forward voltage	V_{F}	I _F = 25.0 A	T _{vj} = 25 °C		1.65	2.15	V
			T _{vj} = 175 °C		1.60		
Reverse leakage current	I _R	V _R = 1200 V	T _{vj} = 25 °C			40	μΑ
			T _{vj} = 175 °C		2000		
Diode reverse recovery time	t _{rr}	$V_{\rm R} = 600 \text{ V}, R_{\rm Gon} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm F}$ = 25.0 A		150		ns
			$T_{\rm vj} = 175 ^{\circ}\text{C},$ $I_{\rm F} = 25.0 ^{\circ}\text{A}$		270		
Diode reverse recovery charge	Q _{rr}	$V_{\rm R} = 600 \text{ V}, R_{\rm Gon} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm F}$ = 25.0 A		1.45		μC
			$T_{\rm vj} = 175 ^{\circ}\text{C},$ $I_{\rm F} = 25.0 \text{A}$		3.60		

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3 Diode

Table 5 Characteristic values (continued)

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Diode peak reverse recovery current	I _{rrm}	$V_{\rm R} = 600 \text{ V}, R_{\rm Gon} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm F}$ = 25.0 A		23.9		А
			$T_{\rm vj}$ = 175 °C, $I_{\rm F}$ = 25.0 A		33.5		
Diode peak rate off fall of reverse recovery current		$T_{\rm vj} = 25 ^{\circ}\text{C},$ $I_{\rm F} = 25.0 \text{A}$		-220		A/µs	
			$T_{\rm vj}$ = 175 °C, $I_{\rm F}$ = 25.0 A		-150		
Reverse recovery energy	E _{rec}	$V_{\rm R} = 600 \text{ V}, R_{\rm Gon} = 6.0 \Omega$	$T_{\rm vj}$ = 25 °C, $I_{\rm F}$ = 25.0 A		0.45		mJ
			$T_{\rm vj}$ = 175 °C, $I_{\rm F}$ = 25.0 A		1.35		
Diode thermal resistance, junction-case	R _{thjc}				0.90	1.25	K/W
Operating junction temperature	$T_{\rm vj}$			-40		175	°C

Note:

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

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Dynamic test circuit, parasitic inductance L_{σ} = 30 nH, C_{σ} = 13 pF

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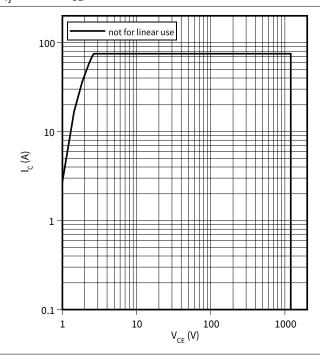
4 Characteristics diagrams

4 Characteristics diagrams

Reverse bias safe operating area, IGBT

 $I_C = f(V_{CE})$

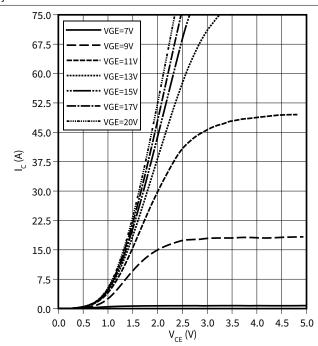
 $T_{vi} \le 175$ °C, $V_{GE} = 15$ V



Typical output characteristic, IGBT

 $I_C = f(V_{CE})$

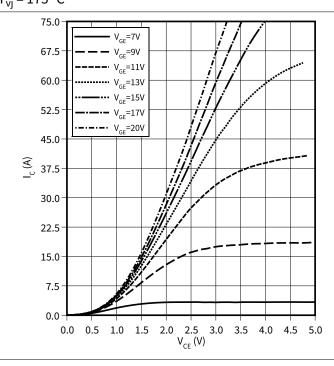
 $T_{vj} = 25 \,^{\circ}C$



Typical output characteristic, IGBT

 $I_C = f(V_{CE})$

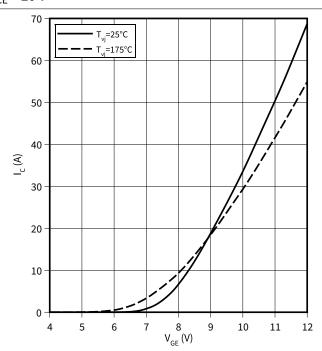
T_{vj} = 175 °C



Typical transfer characteristic, IGBT

 $I_C = f(V_{GE})$

 $V_{CE} = 20 V$



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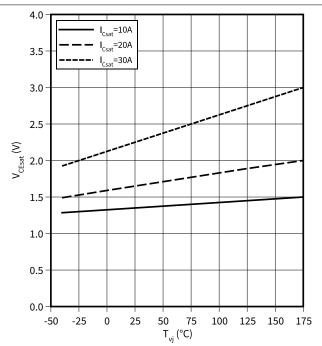


4 Characteristics diagrams

Typical collector-emitter saturation voltage as a function of junction temperature, IGBT

$$V_{CEsat} = f(T_{vj})$$

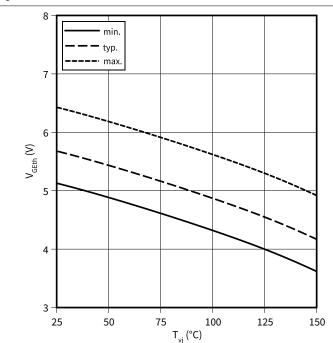
$$V_{GE} = 15 V$$



Gate-emitter threshold voltage as a function of junction temperature, IGBT

$$V_{GEth} = f(T_{vj})$$

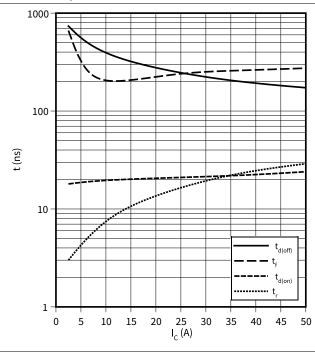
$$I_{C} = 0.49 \text{ mA}$$



Typical switching times as a function of collector current, IGBT

 $t = f(I_C)$

$$V_{CE}$$
 = 600 V, T_{vj} = 175 °C, V_{GE} = 0/15 V, R_{G} = 6.0 Ω

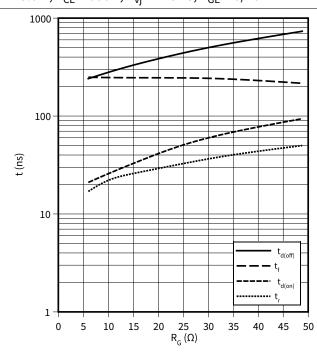


Typical switching times as a function of gate resistor, IGBT

 $t = f(R_G)$

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$$I_C = 25.0 \text{ A}, V_{CE} = 600 \text{ V}, T_{vi} = 175 \,^{\circ}\text{C}, V_{GE} = 0/15 \text{ V}$$



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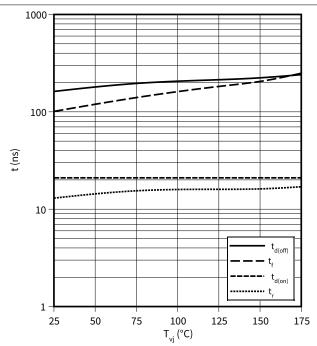


4 Characteristics diagrams

Typical switching times as a function of junction temperature, IGBT

$$t = f(T_{vj})$$

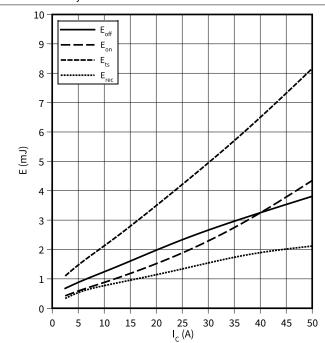
$$I_C$$
 = 25.0 A, V_{CE} = 600 V, V_{GE} = 0/15 V, R_G = 6.0 Ω



Typical switching energy losses as a function of collector current, IGBT

$$E = f(I_C)$$

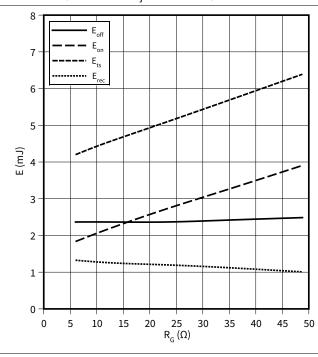
$$V_{CE} = 600 \text{ V}, T_{vj} = 175 \,^{\circ}\text{C}, V_{GE} = 0/15 \,^{\circ}\text{V}, R_{G} = 6.0 \,^{\circ}\Omega$$



Typical switching energy losses as a function of gate resistor, IGBT

 $E = f(R_G)$

$$I_C = 25.0 \text{ A}, V_{CE} = 600 \text{ V}, T_{vi} = 175 \,^{\circ}\text{C}, V_{GE} = 0/15 \text{ V}$$

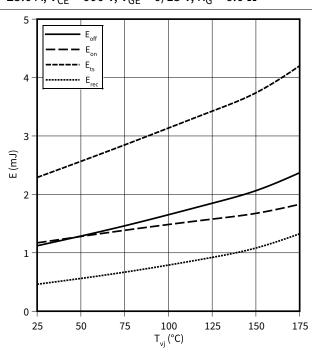


Typical switching energy losses as a function of junction temperature, IGBT

 $E = f(T_{vi})$

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$$I_C$$
 = 25.0 A, V_{CE} = 600 V, V_{GE} = 0/15 V, R_G = 6.0 Ω



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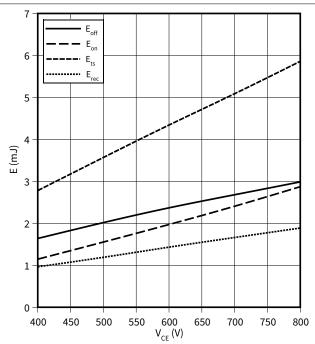


4 Characteristics diagrams

Typical switching energy losses as a function of collector emitter voltage, IGBT

 $E = f(V_{CE})$

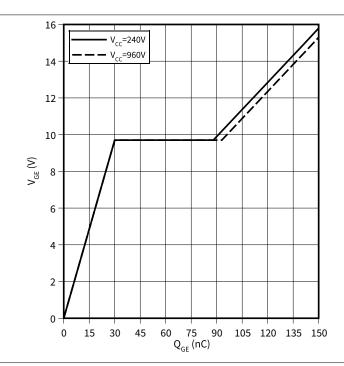
$$T_{vi} = 175 \,^{\circ}\text{C}, I_{C} = 25.0 \,\text{A}, V_{GE} = 0/15 \,\text{V}, R_{G} = 6.0 \,\Omega$$



Typical gate charge, IGBT

 $V_{GE} = f(Q_{GE})$

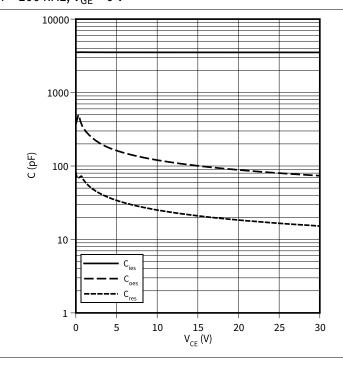
$$I_C = 25.0 A$$



Typical capacitance as a function of collector-emitter voltage, IGBT

 $C = f(V_{CE})$

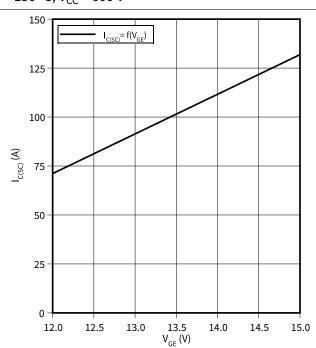
 $f = 100 \text{ kHz}, V_{GF} = 0 \text{ V}$



Typical short circuit collector current as a function of gate-emitter voltage, IGBT

 $I_{C(SC)} = f(V_{GE})$

 $T_{vi} = 150 \,^{\circ}\text{C}, \, V_{CC} = 600 \,^{\circ}\text{V}$



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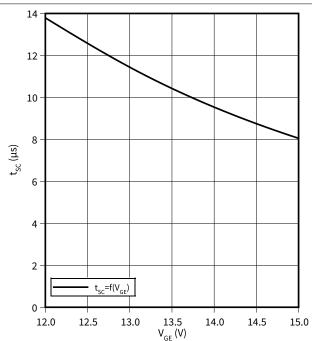


4 Characteristics diagrams

Short circuit withstand time as a function of gateemitter voltage, IGBT

$$t_{SC} = f(V_{GE})$$

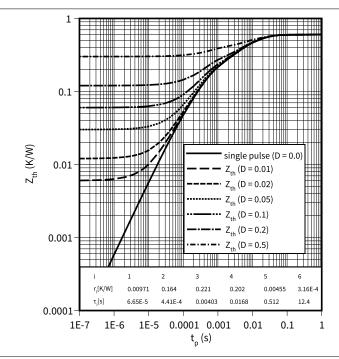
$$T_{vi} \le 150 \,^{\circ}\text{C}, V_{CC} = 600 \,\text{V}$$



IGBT transient thermal impedance, IGBT

$$Z_{th} = f(t_p)$$

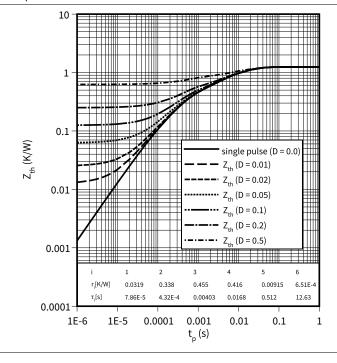
$$D = t_p/T$$



Diode transient thermal impedance as a function of pulse width, Diode

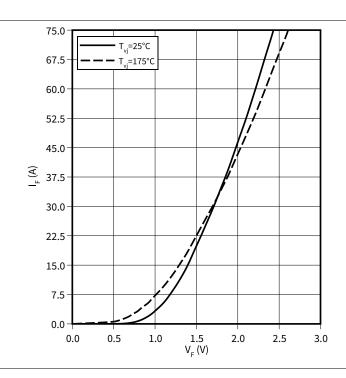
$$Z_{th} = f(t_p)$$

$$D = t_p/T$$



Typical diode forward current as a function of forward voltage, Diode

$$I_F = f(V_F)$$



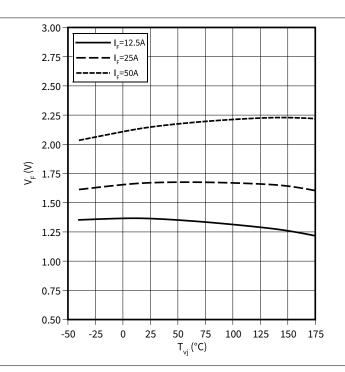
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4 Characteristics diagrams

Typical diode forward voltage as a function of junction temperature, Diode

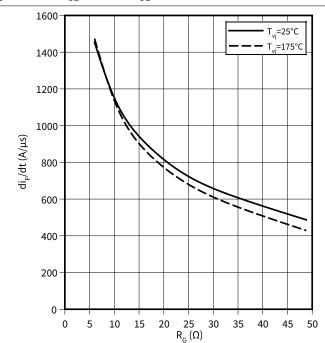
$$V_F = f(T_{vj})$$



Typical diode current slope as a function of gate resistor, Diode

 $di_F/dt = f(R_G)$

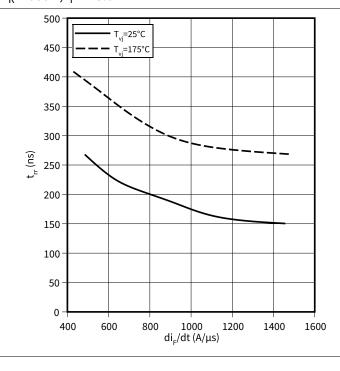
 I_C = 25.0 A, V_{CE} = 600 V, V_{GE} = 0/15 V



Typical reverse recovery time as a function of diode current slope, Diode

$$t_{rr} = f(di_F/dt)$$

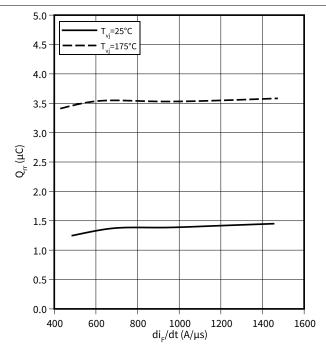
 $V_R = 600 \text{ V}, I_F = 25.0 \text{ A}$



Typical reverse recovery charge as a function of diode current slope, Diode

 $Q_{rr} = f(di_F/dt)$

 $V_R = 600 \text{ V}, I_F = 25.0 \text{ A}$



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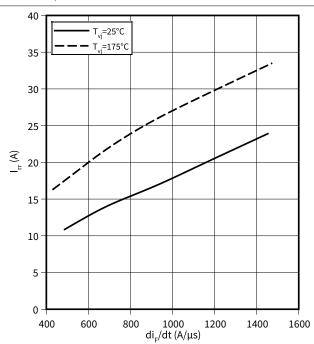


4 Characteristics diagrams

Typical reverse recovery current as a function of diode current slope, Diode

$$I_{rr} = f(di_F/dt)$$

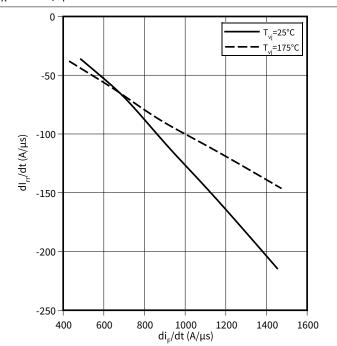
$$V_R = 600 \text{ V}, I_F = 25.0 \text{ A}$$



Typical diode peak rate of fall of reverse recovery current as a function of diode current slope, Diode

$$dI_{rr}/dt = f(di_F/dt)$$

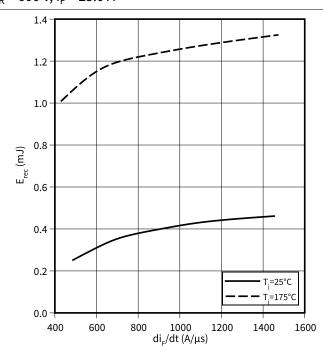
$$V_R = 600 \text{ V}, I_F = 25.0 \text{ A}$$



Typical reverse energy losses as a function of diode current slope, Diode

$$E_{rec} = f(di_F/dt)$$

$$V_R = 600 \text{ V}, I_F = 25.0 \text{ A}$$



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Short circuit rugged 1200 V TRENCHSTOP™ IGBT 7 technology



5 Package outlines

5 Package outlines

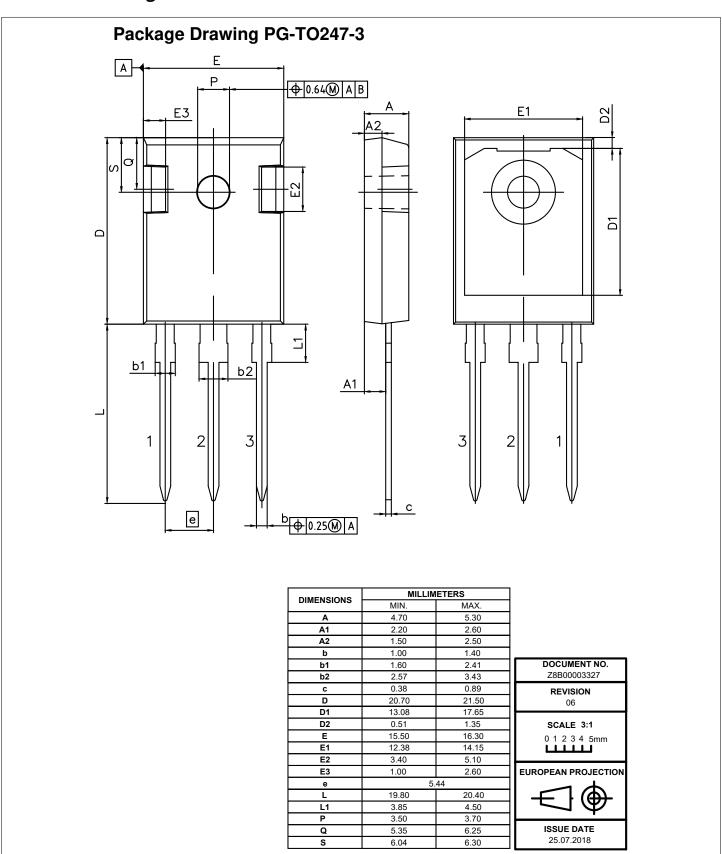


Figure 6



6 Testing conditions

6 Testing conditions

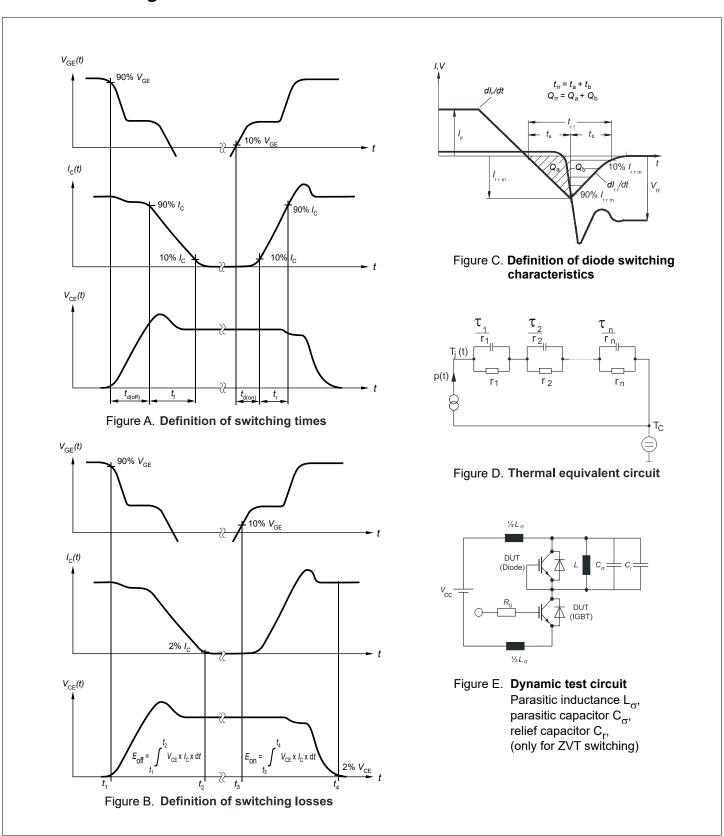


Figure 7

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